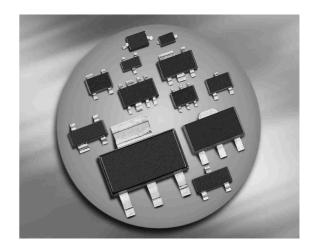


NPN Silicon AF Transistor

- For general AF applications
- High collector current
- High current gain
- Low collector-emitter saturation voltage
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101







Туре	Marking	Pin Configuration			
BC817K-16	6As 1 =	3 2 = E 3 = C	SOT23		
BC817K-16W	6As 1 =	3 2 = E 3 = C	SOT323		
BC817K-25	6Bs 1 =	3 2 = E 3 = C	SOT23		
BC817K-25W	6Bs 1 =	3 2 = E 3 = C	SOT323		
BC817K-40	6Cs 1 =	3 2 = E 3 = C	SOT23		
BC817K-40W	6Cs 1 =	3 2 = E 3 = C	SOT323		
BC818K-16W	6Es 1 =	3 2 = E 3 = C	SOT323		
BC818K-40	6Gs 1 =	3 2 = E 3 = C	SOT23		



Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CEO}		V
BC817		45	
BC818		25	
Collector-base voltage	V _{CBO}		
BC817		50	
BC818		30	
Emitter-base voltage	V_{EBO}	5	
Collector current	I _C	500	mA
Peak collector current	I _{CM}	1000	
Base current	I _B	100	
Peak base current	I _{BM}	200	
Total power dissipation-	P _{tot}		mW
<i>T</i> _S ≤ 115 °C, BC817K, BC818K		500	
$T_{\rm S} \leq$ 130 °C, BC817KW, BC818KW		250	
Junction temperature	$T_{\rm j}$	150	°C
Storage temperature	T _{stg}	-65 150	

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}		K/W
BC817K, BC818K		≤ 70	
BC817KW, BC818KW		≤ 80	

 $^{^{1}}$ For calculation of R_{thJA} please refer to Application Note AN077 (Thermal Resistance Calculation)



Electrical Characteristics at T_{Δ} = 25°C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					
Collector-emitter breakdown voltage	V _{(BR)CEO}				V
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0 , BC817		45	-	-	
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0 , BC818		25	-	-	
Collector-base breakdown voltage	V _{(BR)CBO}				-
$I_{\rm C}$ = 10 $\mu{\rm A},\ I_{\rm E}$ = 0 , BC817		50	-	-	
$I_{\rm C}$ = 10 μ A, $I_{\rm E}$ = 0 , BC818		30	-	-	
Emitter-base breakdown voltage	V _{(BR)EBO}	5	-	-	V
$I_{\rm E} = 10 \ \mu A, I_{\rm C} = 0$					
Collector-base cutoff current	I _{CBO}				μA
$V_{\rm CB} = 25 \text{V}, I_{\rm E} = 0$		-	-	0.1	
V_{CB} = 25 V, I_{E} = 0 , T_{A} = 150 °C		-	-	50	
Emitter-base cutoff current	I _{EBO}	-	-	100	nA
$V_{\rm EB} = 4 \text{ V}, I_{\rm C} = 0$					
DC current gain ¹⁾	h _{FE}				-
$I_{\rm C}$ = 100 mA, $V_{\rm CE}$ = 1 V, $h_{\rm FE}$ -grp.16		100	160	250	
$I_{\rm C}$ = 100 mA, $V_{\rm CE}$ = 1 V, $h_{\rm FE}$ -grp.25		160	250	400	
$I_{\rm C}$ = 100 mA, $V_{\rm CE}$ = 1 V, $h_{\rm FE}$ -grp.40		250	350	630	
$I_{\rm C}$ = 500 mA, $V_{\rm CE}$ = 1 V, all $h_{\rm FE}$ -grps.		40	-	-	
Collector-emitter saturation voltage ¹⁾	V _{CEsat}	-	-	0.7	V
$I_{\rm C}$ = 500 mA, $I_{\rm B}$ = 50 mA					
Base emitter saturation voltage ¹⁾	V _{BEsat}	-	-	1.2	
$I_{\rm C}$ = 500 mA, $I_{\rm B}$ = 50 mA					

¹Pulse test: $t < 300\mu s$; D < 2%





Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

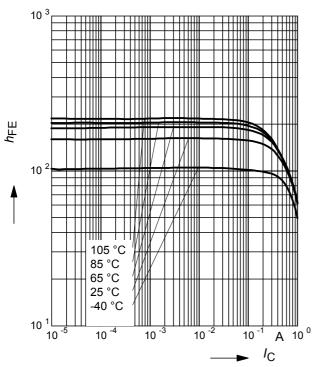
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics					
Transition frequency	f_{T}	-	170	-	MHz
$I_{\rm C}$ = 50 mA, $V_{\rm CE}$ = 5 V, f = 100 MHz					
Collector-base capacitance	C _{cb}	-	3	-	pF
$V_{CB} = 10 \text{ V}, f = 1 \text{ MHz}$					
Emitter-base capacitance	C _{eb}	-	40	-	
$V_{\rm EB}$ = 0.5 V, f = 1 MHz					



DC current gain $h_{FE} = f(I_C)$

 $V_{CE} = 1 \text{ V}$

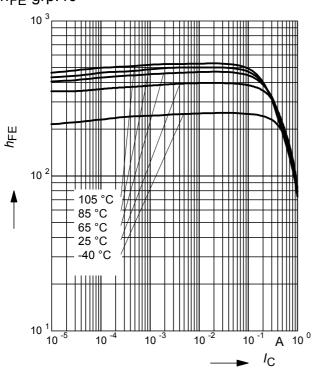
h_{FE}-grp.16



DC current gain $h_{FE} = f(I_C)$

 $V_{CE} = 1 \text{ V}$

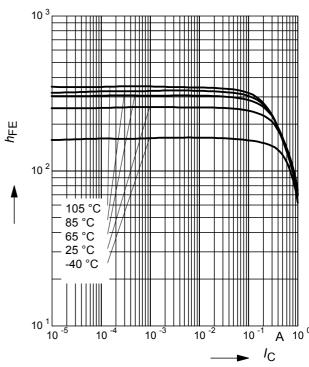
h_{FE}-grp.40



DC current gain $h_{FE} = f(I_C)$

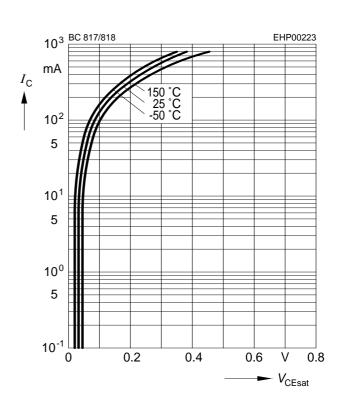
 $V_{CE} = 1 \text{ V}$

h_{FE}-grp.25



Collector-emitter saturation voltage

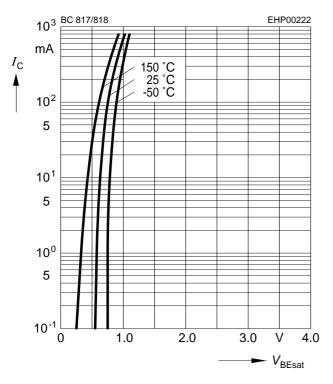
$$I_{\text{C}} = f(V_{\text{CEsat}}), h_{\text{FE}} = 10$$





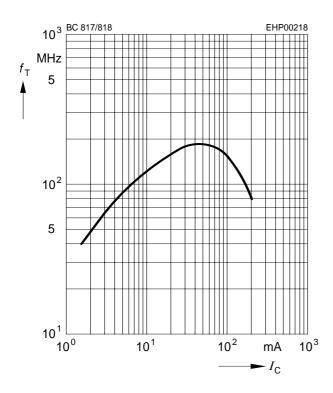
Base-emitter saturation voltage

$$I_{\rm C} = f(V_{\rm BEsat}), h_{\rm FE} = 10$$



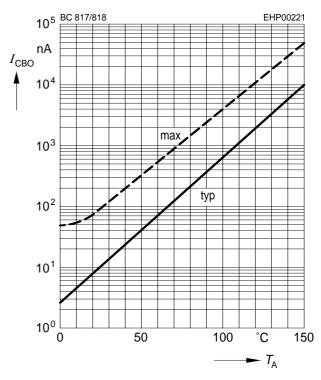
Transition frequency $f_T = f(I_C)$

 V_{CE} = parameter in V, f = 2 GHz

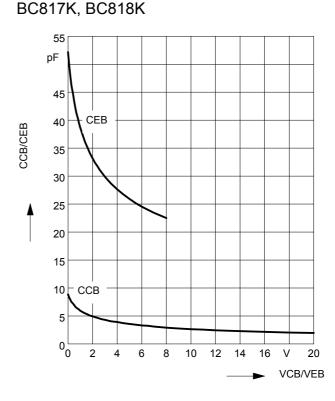


Collector cutoff current $I_{CBO} = f(T_A)$

$$V_{\rm CBO}$$
 = 25 V

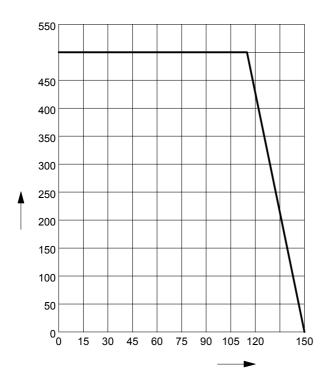


Collector-base capacitance $C_{cb} = f(V_{CB})$ Emitter-base capacitance $C_{eb} = f(V_{EB})$

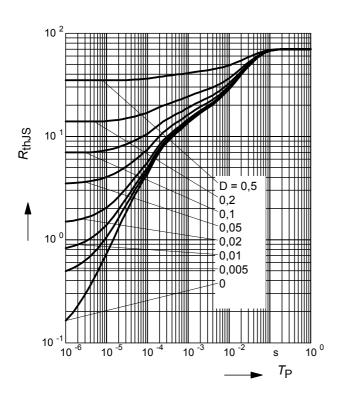




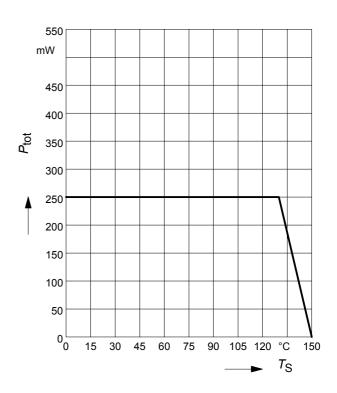
Total power dissipation $P_{tot} = f(T_S)$ BC817K, BC818K



Permissible Pulse Load $R_{thJS} = f(t_p)$ BC817K, BC818K

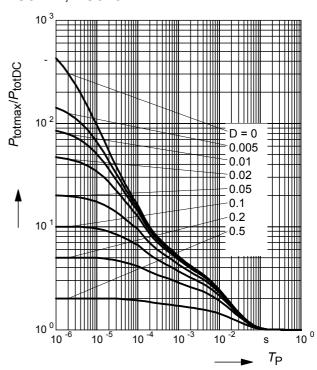


Total power dissipation $P_{tot} = f(T_S)$ BC817KW, BC818KW



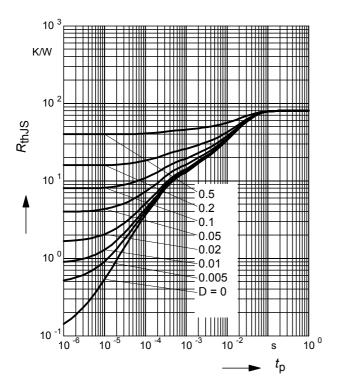
Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{\text{p}})$ BC817K, BC818K



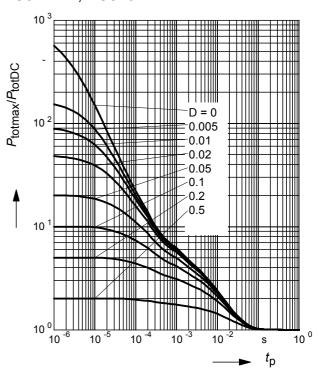


Permissible Puls Load R_{thJS} = $f(t_p)$ BC817KW, BC818KW



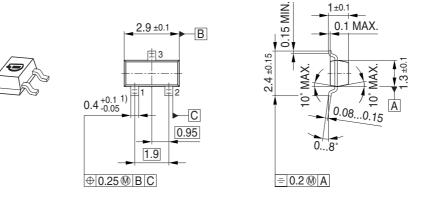
Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{\text{p}})$ BC817KW, BC818KW

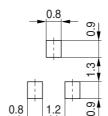




Package Outline

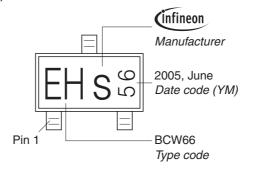


Foot Print



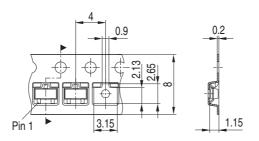
1) Lead width can be 0.6 max. in dambar area

Marking Layout (Example)



Standard Packing

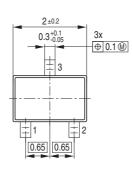
Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel

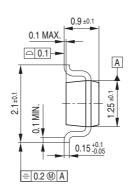




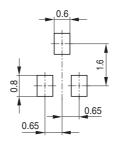
Package Outline



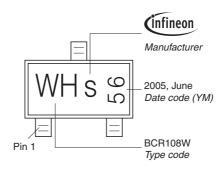




Foot Print

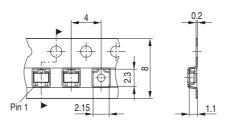


Marking Layout (Example)



Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel





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